Notice of References Cited Application/Control No. 10/634,092 Examiner Minh Dieu Nguyen Applicant(s)/Patent Under Reexamination VOGLER ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	· Name	Classification
*	Α	US-7,233,948	06-2007	Shamoon et al.	707/9
*	В	US-2003/0068043	04-2003	Tam et al.	380/236
*	С	US-6,988,277	01-2006	Kovac et al.	725/34
*	D	US-2003/0051237	03-2003	Sako et al.	725/31
*	Е	US-2001/0016834	08-2001	Yamanaka et al.	705/40
*	F	US-2002/0077902	06-2002	Marcus, Dwight	705/14
*	G	US-2003/0154378	08-2003	Hirano, Hideyuki	713/176
	H	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-	,		

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	1					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	V			
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	x			

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